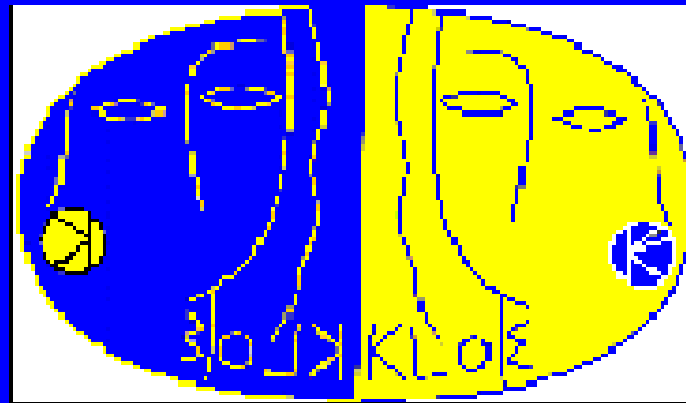


$$R=K_L \rightarrow \gamma\gamma / K_L \rightarrow \pi^+ \pi^+ \pi^0$$

(a brief report)

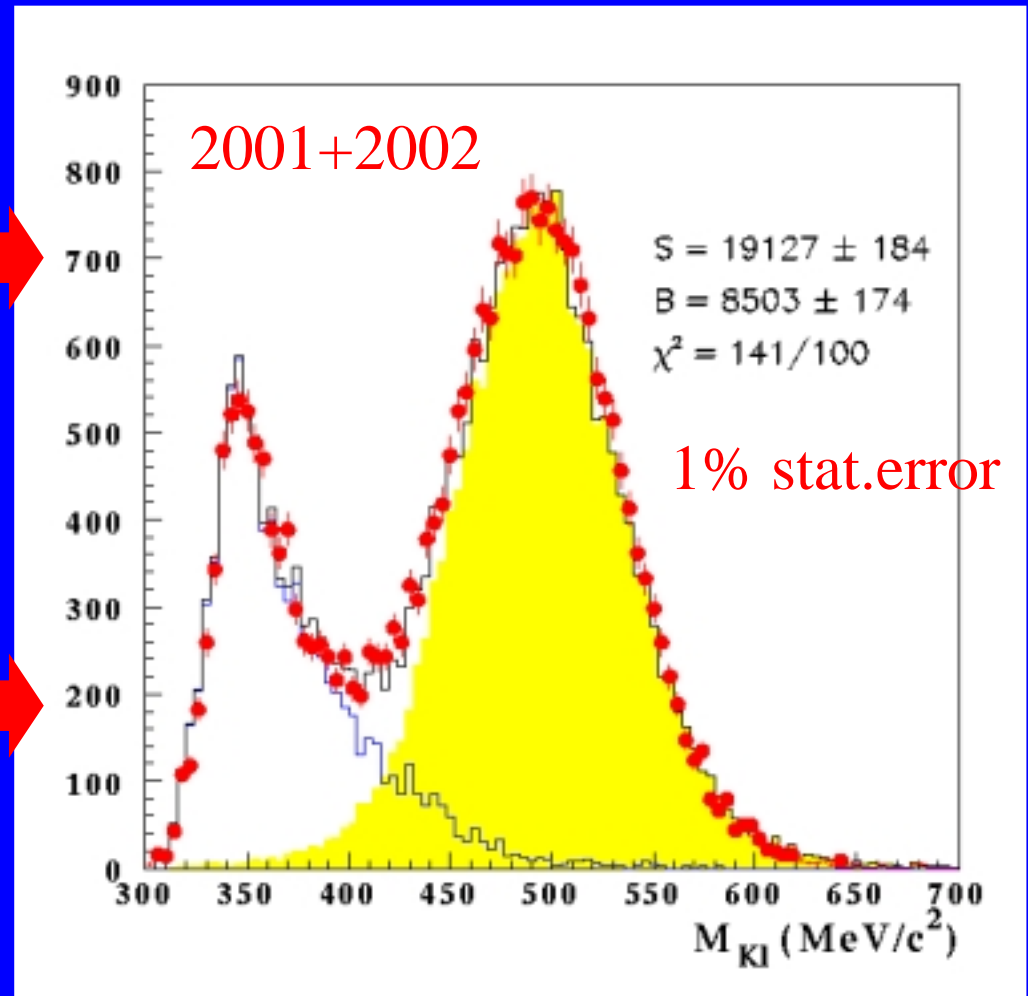
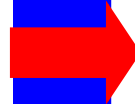
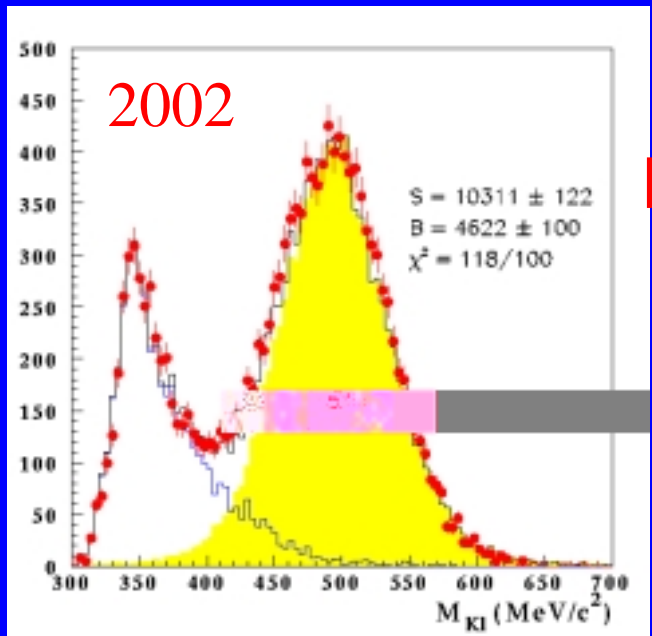
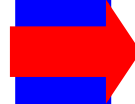
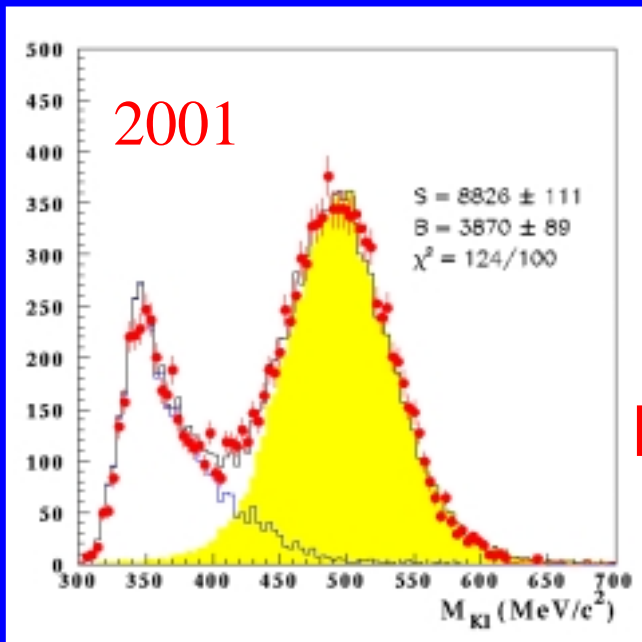
G. Lanfranchi - KLOE General Meeting - Dec '02



Major improvements:

- Analyzed statistics : 2001 : 142.6 pb⁻¹
2002 : 169.4 pb⁻¹
2001+2002: 312 pb⁻¹ (3568 runs)
- Massive Monte Carlo production for $K_L \rightarrow \gamma\gamma$ background study:
150 pb⁻¹ of $K_S \rightarrow \pi^+\pi^-$, $K_L \rightarrow$ all
- Small refinements in the analysis cuts to improve systematic errors

The $K \rightarrow \gamma\gamma$ sample:



Efficiencies:

$$\epsilon (\text{trigger}) = (99.6 \pm 0.06 \text{ stat} \pm 0.1 \text{ syst})\%$$

$$\epsilon (\text{filter}) = (89.5 \pm 0.1 \text{ stat} \pm 0.4 \text{ syst})\% \quad (93.6\% \text{ acceptance})$$

$$\epsilon (\text{selection}) = (91.1 \pm 0.4 \text{ stat} \pm 0.5 \text{ syst})\%$$

$$\epsilon (\text{total}) = (81.1 \pm 0.4 \text{ stat} \pm 0.5 \text{ syst}) \%$$

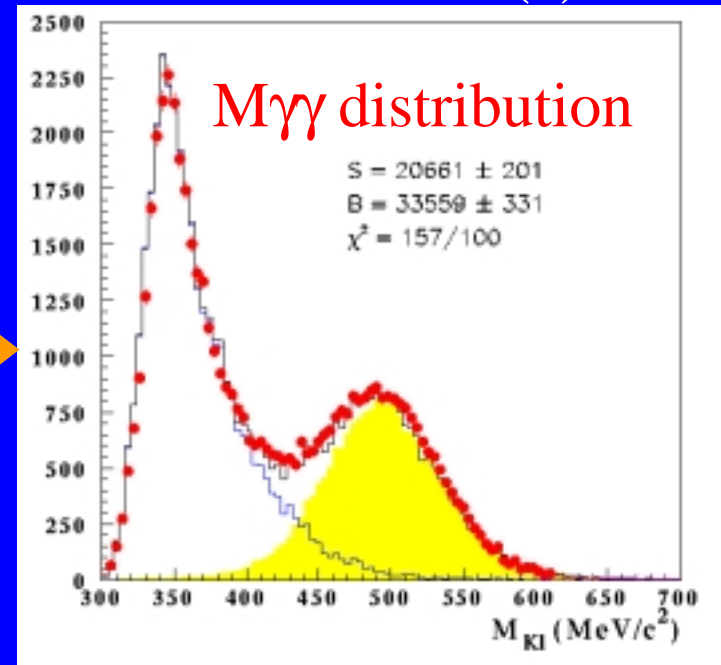
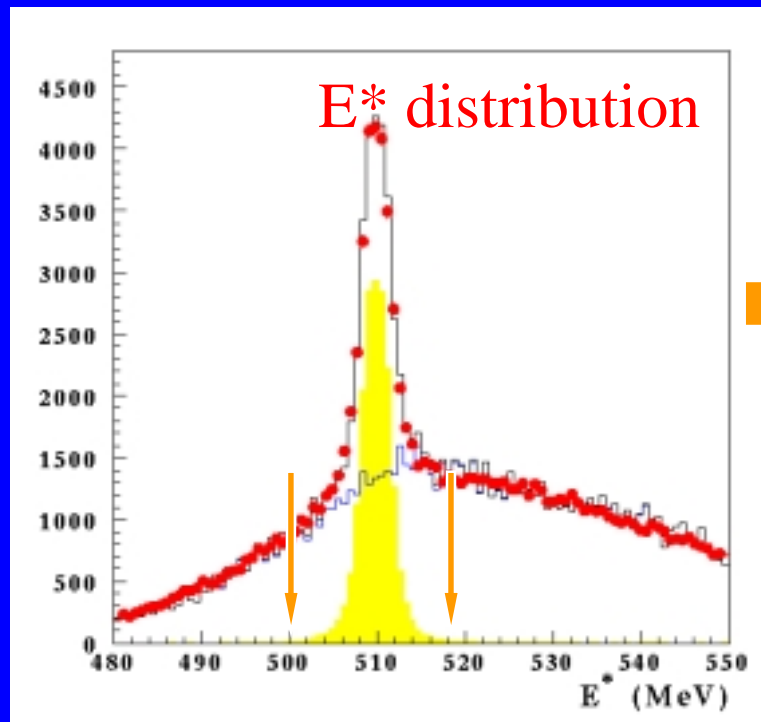
Selection done with only two and very loose cuts:

1) $|E^* - \mu| < 5 \sigma$

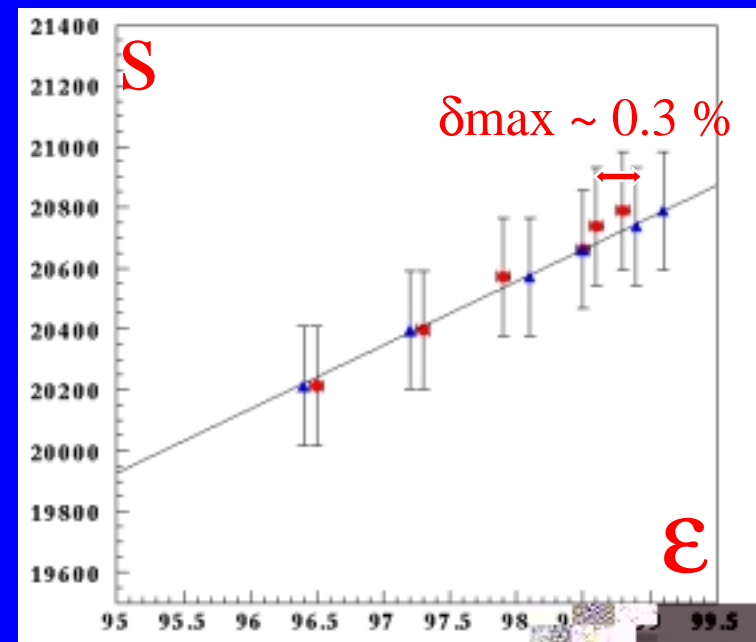
2) $\alpha < 15^\circ$

Efficiencies estimated from data

Systematics on the selection cuts (I)



- 1) Cut moved from 3 $\sigma \rightarrow 6 \sigma$
- 2) Fit the $M_{\gamma\gamma}$ to get the signal content
- 3) Evaluate max displacement between the measured efficiencies and the nominal ones.

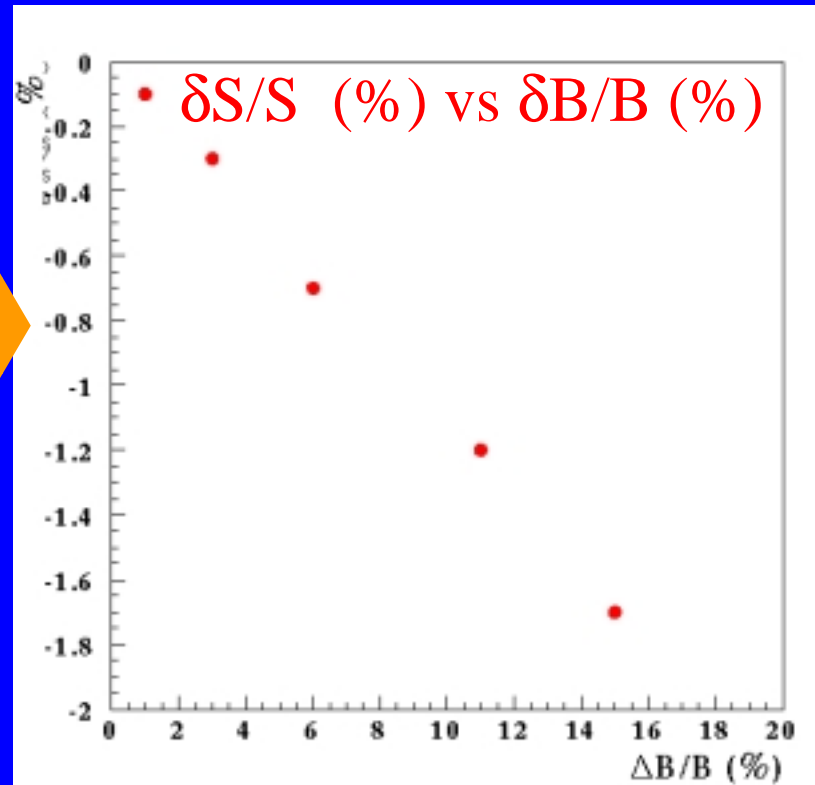
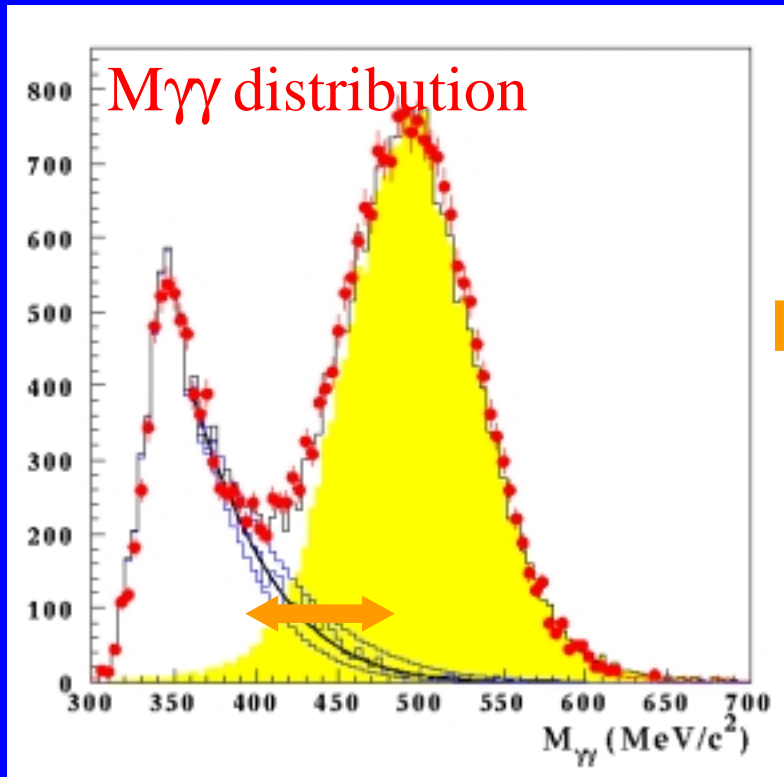


Systematics on the selection cuts (II)



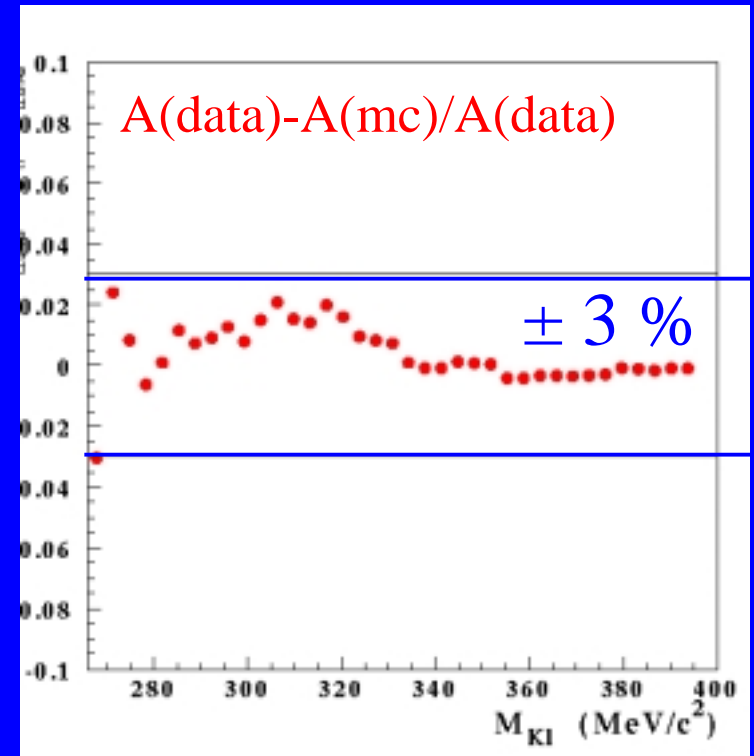
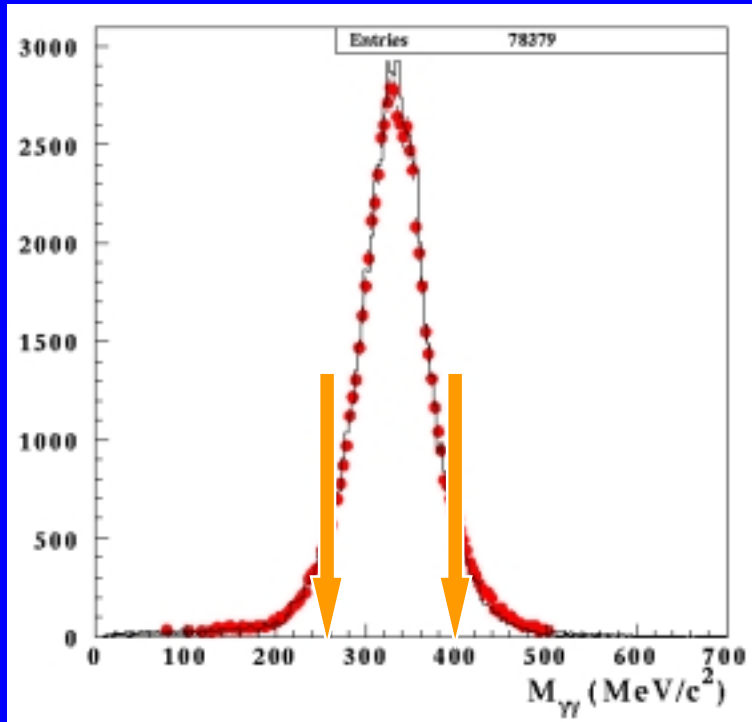
- 1) Cut moved from 10° to 22°
- 2) Fit the $M_{\gamma\gamma}$ to get the signal content
- 3) Evaluate max displacement between the measured efficiency and the nominal one.

Systematics on the background evaluation (I)



Background content in the signal window changed by an amount between $\pm 16\%$. The effect on the signal content is **10 times smaller**.

Systematics on the background evaluation (II)

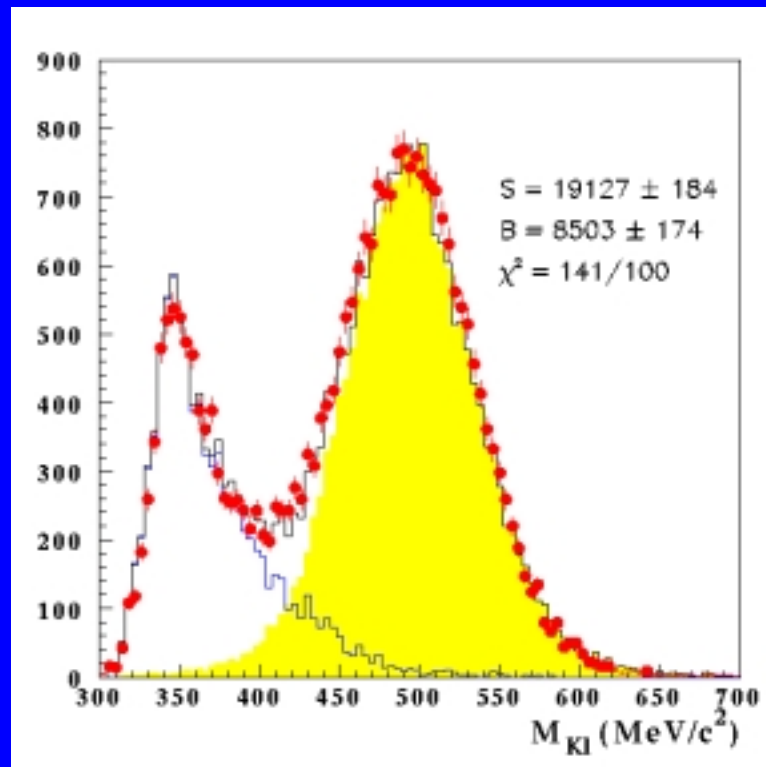


Shape of background studied in the range 280-400 MeV
Max difference in the cumulative distributions: 3 %



$$\delta N_{\gamma\gamma} / N_{\gamma\gamma} (\text{bkg}) = 0.3 \%$$

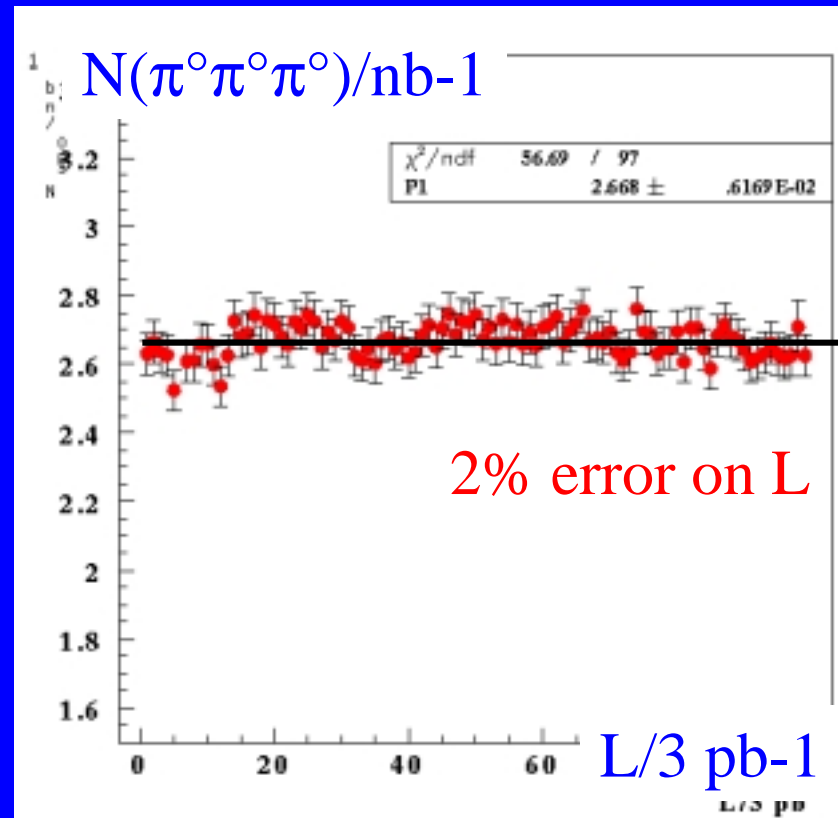
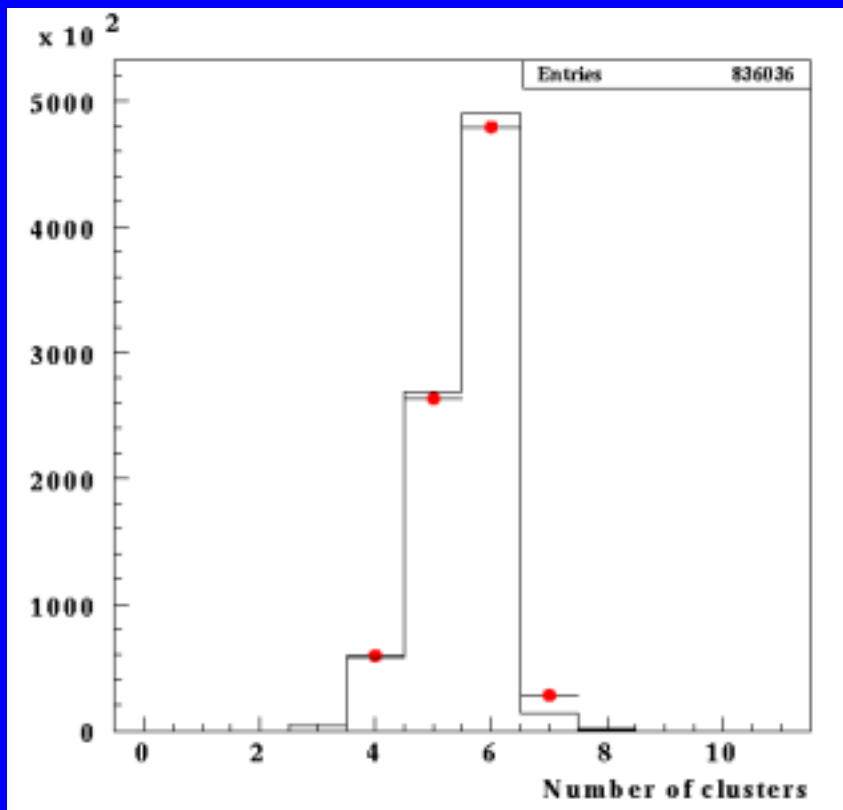
$N_{\gamma\gamma}$ final counting



$$\varepsilon (\text{total}) = (81.1 \pm 0.4 \text{ stat} \pm 0.5 \text{ syst}) \%$$

$$N_{\gamma\gamma} = 23584 \pm 236 (1\%) \text{ stat} \pm 212 (0.9\%) \text{ syst}$$

$K_L \rightarrow \pi^0 \pi^0 \pi^0$ sample (I)

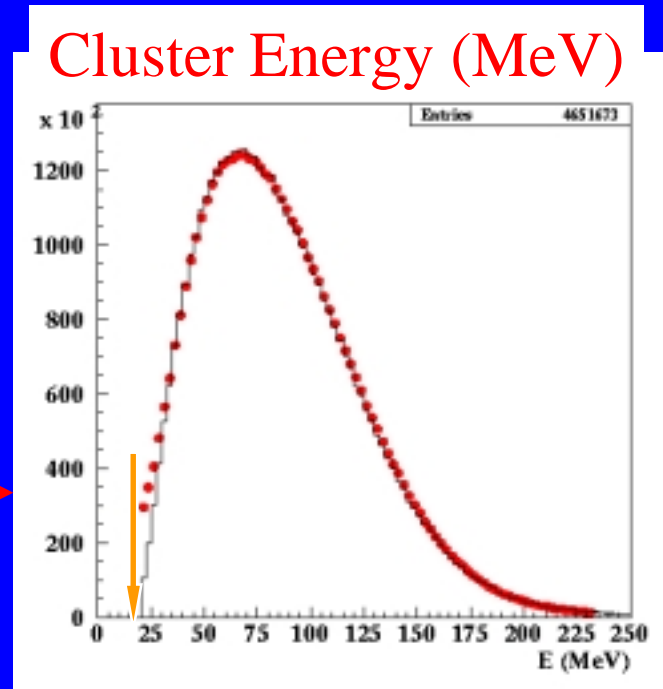
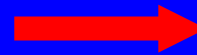


$N \pi^0 \pi^0 \pi^0 = 8429732 \pm 920$ (0.1%) stat ± 16800 (0.2%) syst

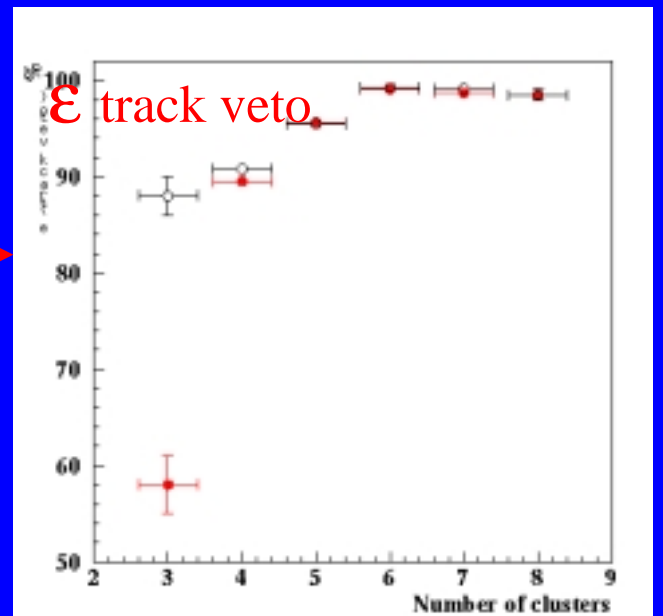
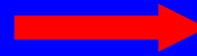
$K_L \rightarrow \pi^0 \pi^0 \pi^0$ sample (II)

Small refinements:

1) cluster threshold moved
from 7 MeV \rightarrow 20 MeV
(0.2% lost of events but helps
in reducing contamination...)

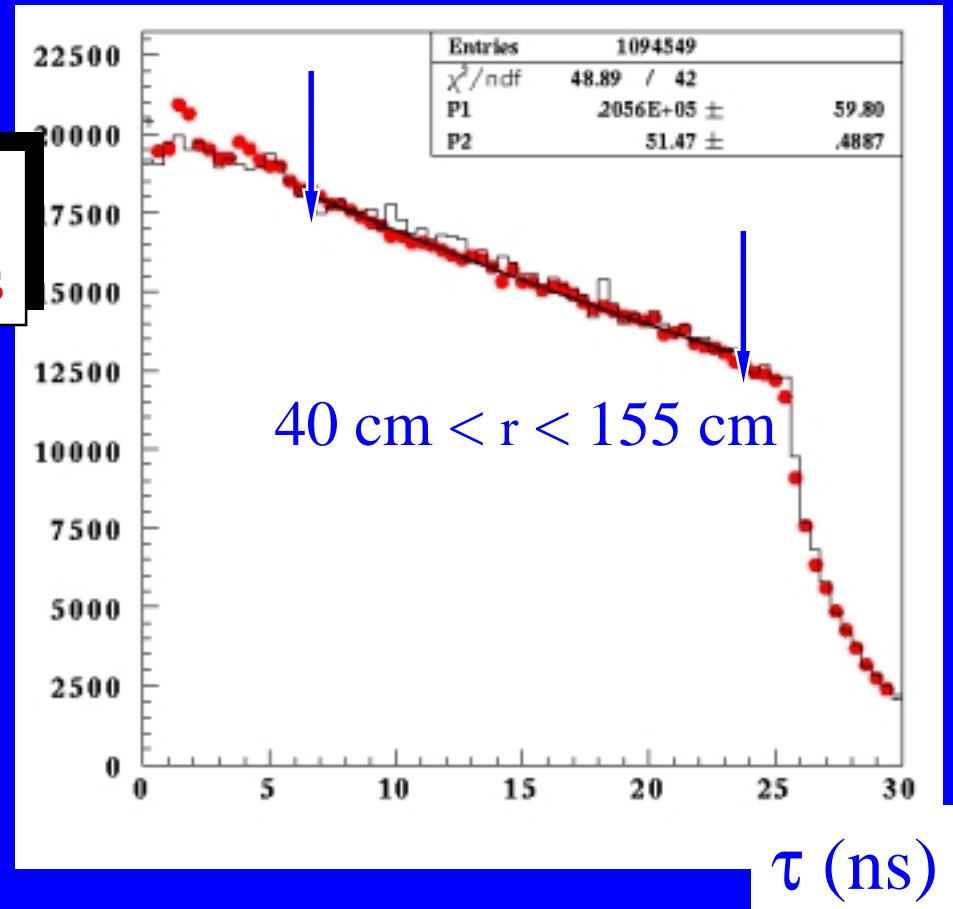


2) Looser track veto:
distance (Kl vertex - first hit) < 50 cm



$K_L \rightarrow \pi^0 \pi^0 \pi^0$ sample : lifetime

τ (KLOE) = (51.5 ± 0.5) ns
 τ (PDG02) = (51.7 ± 0.4) ns



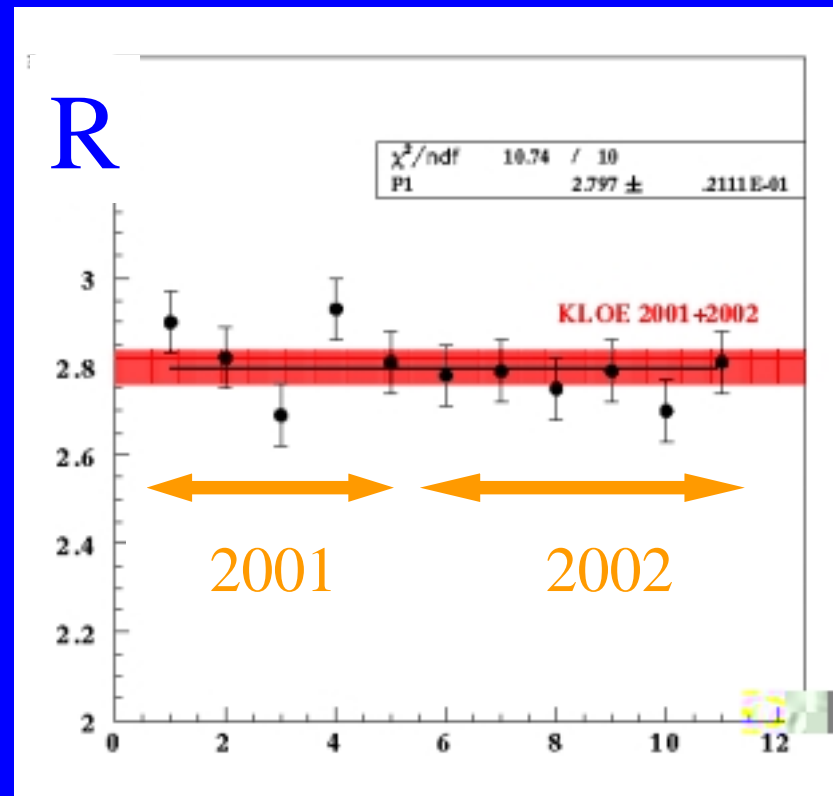
...Already at the PDG accuracy level using just 10% (30 pb⁻¹) of data sample....

$$R = K_L \rightarrow \gamma\gamma / K_L \rightarrow \pi^0\pi^0\pi^0$$

KLOE (02) = $(2.797 \pm 0.028 \text{ stat} \pm 0.025 \text{ syst}) 10^{-3}$

NA48 (02) = $(2.81 \pm 0.01 \text{ stat} \pm 0.03 \text{ syst}) 10^{-3}$ (hep-ex/0210053)

PDG(00) = $(2.77 \pm 0.08) 10^{-3}$ (from a fit)



Conclusions

R has been measured at 1% statistical error and 0.9 % systematic error using 312 pb-1 of 2001 and 2002 KLOE data sample .

- KLOE note in preparation followed by a paper draft.

- The result confirms the only other existing direct measurement (NA48, october 02) with a comparable accuracy.

- The error on $BR(KL \rightarrow \gamma\gamma)$ is anyhow affected by the uncertainty on the $BR(KL \rightarrow \pi^0 \pi^0 \pi^0) \sim 1.3\%$:

$$PDG(02) = 2.5 \%$$

$$KLOE(0.2) = 1.8 \%$$

$$NA48(02) = 1.5 \%$$

Future Plans

Measurement of **KL lifetime** using the $KL \rightarrow \pi^0 \pi^0 \pi^0$ decay seems a short term item:

- statistics is not a problem
- neutral vertex reconstruction efficiency wrt decay path length must be studied.

Direct measurement of **$BR(KL \rightarrow \pi^0 \pi^0 \pi^0)$** and of **$BR(KL \rightarrow \gamma \gamma)$** with an improved accuracy wrt PDG are possible if tag efficiency is known at $< 1\%$ level.